MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

Brodnet data speet

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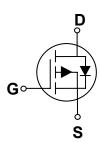
AO3415A HF







SOT-23-3L



Features

- -20 V,-4.5A, RDS(ON)=40mΩ@VGS=-4.5V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
-20V	40mΩ	-4.5A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-20	V
V _G S	Gate-Source Voltage	±12	V
	Drain Current – Continuous (Tc=250)	-4.5	Α
I _D	Drain Current – Continuous (Tc=1000)	-2.7	А
Ірм	Drain Current – Pulsed ¹	-18	А
5	Power Dissipation (T _C =250)	1.5	W
P _D	Power Dissipation – Derate above 250	0.012	W/ C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Rela	Thermal Resistance Junction to ambient		80	c/ W



Off Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =-250uA		-20			V
△ BV _{DSS} / △ T _J	BV _{DSS} Temperature Coefficient Reference to 250 , I _D =-1mA			-0.02		V/ C
	Drain-Source Leakage Current	V _{DS} =-20V , V _{GS} =0V , T _J =250			-1	uA
loss		V _{DS} =-16V , V _{GS} =0V , T _J =1250			-10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±12V , V _{DS} =0V			±100	nA

On Chara	On Characteristics						
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-3A		40	52	mΩ	
NDS(ON)		V_{GS} =-2.5 V , I_D =-2 A		47	65		
V _{GS(th)}	Gate Threshold Voltage	\\=\\	-0.3	-0.65	-1.0	V	
△ V _{GS(th)}	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$		2		mV/ C	
gfs	Forward Transconductance	V _{DS} =-10V , I _S =-3A		7		S	

Dynamic	Dynamic and switching Characteristics					
Qg	Total Gate Charge ^{2,3}			9.6		
Q_{gs}	Gate-Source Charge ^{2, 3}	V_{DS} =-10V , V_{GS} =-4.5V , I_{D} =-3A	-	1.6		nC
Q_{gd}	Gate-Drain Charge ^{2, 3}			2		
$T_{d(on)}$	Turn-On Delay Time ^{2, 3}		-	6		
Tr	Rise Time ^{2,3}	V_{DD} =-10V , V_{GS} =-4.5V , R_{G} =25 Ω	-	21.6		nS
$T_{d(off)}$	Turn-Off Delay Time ^{2,3}	I _D =-1A	-	51		110
T_f	Fall Time ^{2,3}			13.8		
C_{iss}	Input Capacitance			850		
Coss	Output Capacitance	V _{DS} =-10V , V _{GS} =0V , F=1MHz	1	70		pF
Crss	Reverse Transfer Capacitance			55		

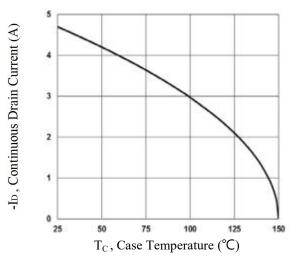
Drain Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V . Force Current			-4.5	Α
Ism	Pulsed Source Current	VG-VD-OV, Poice Current			-9.0	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =-1A , T _J =250			-1.2	V

Note:

- Repetitive Rating: Pulsed width limited by maximum junction temperature. 1.
- 2. The data tested by pulsed , pulse width $\leq 300 \, \text{us}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.





Continuous Drain Current vs. T_{c}

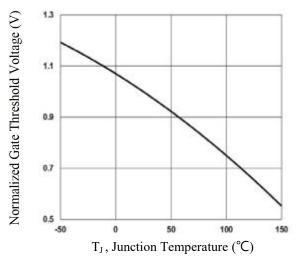
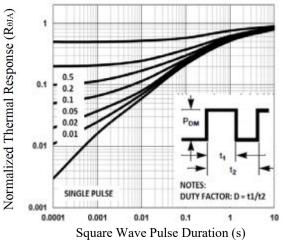
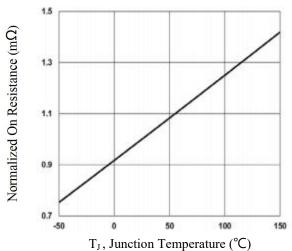


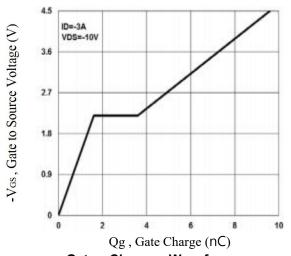
Fig. 3 Normalized V_{th} vs. T_J



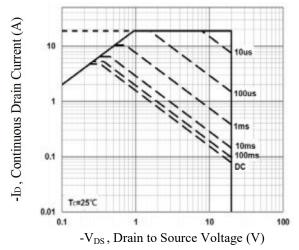
Normalized Transient **Impedance**



Normalized RDSON vs. T_J Fig. 2

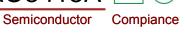


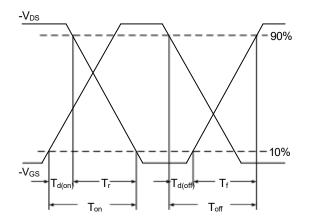
Gate Charge Waveform Fig. 4



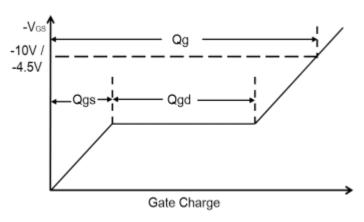
Maximum Safe Operation Area Fig. 6





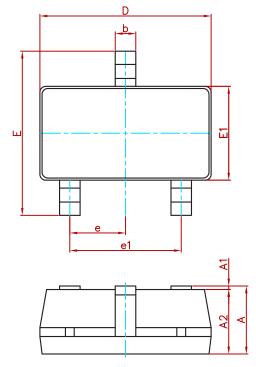


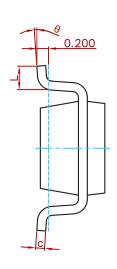




Gate Charge Waveform Fig. 8

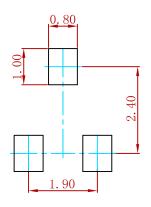
PACKAGE MECHANICAL DATA





Symbol	Dimensions In	Dimensions In Millimeters		s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.037((BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO3415A	SOT-23-3L	3000



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